PMI Studies of Lithium

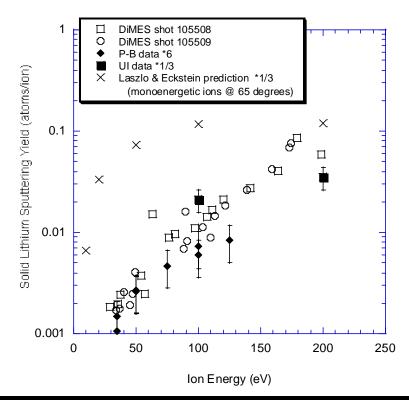
Presented by Russ Doerner and Matt Baldwin

with contributions from G. Antar, D. W. Whyte, as well as the PISCES, CDX-U and DiMES Teams

- Mechanisms for material loss from lithium plasma-facing components
- Hydrogen/deuterium interactions with, and retention in, liquid lithium

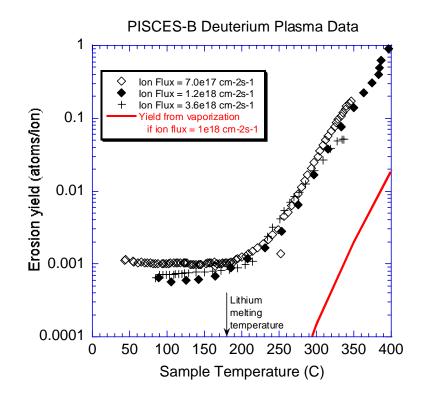
Neutral lithium atom sputtering yield from solid lithium shows good agreement between DiMES, PISCES-B and IIAX data, but less than predicted.

- In order to compared measured yields, they are normalized to show expected Lithium yield vs. D+ incident energy at ~45-60° angle of incidence
 - DiMES: $T_e *5 = E_{ion}$
 - PISCES-B: Yield *6 (from L&E angular dependence data)
 - IIAX: Yield *1/3 (neutral sputtered fraction)
- Comparing material loss rates from liquid lithium samples is still a challenge



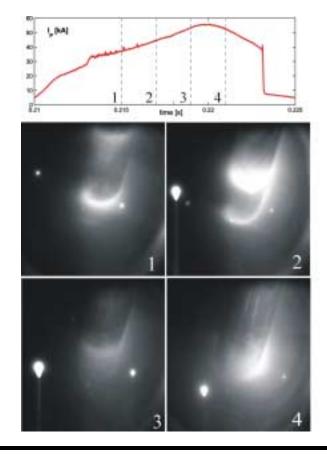
Erosion yield of liquid lithium depends on sample temperature.

- PISCES-B data shows a strong temperature dependence of erosion yield above 200°C
- University of Illinois (IIAX) data shows little difference between sputtering from solid and liquid (at 200°C) targets
- Difficulty keeping DiMES sample stationary inhibits measurements during the liquid phase



Current flow from the plasma (JxB) into conducting plasma-facing component may prove to be the most restrictive constraint on the use of liquid metals.

- JxB dominates the forces in the lithium on the CDX-U limiter and may be responsible for the ejection of droplets into the plasma
- During liquid lithium DiMES exposure, the JxB force may result in the propulsion of the entire lithium sample into the core
- Non-normal incidence magnetic field experiments are being implemented in PISCES



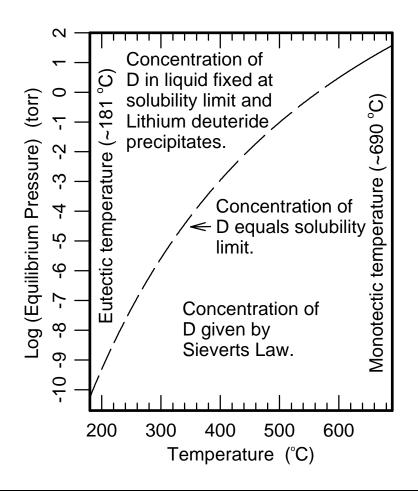
Retention of Deuterium in Liquid Lithium

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Decomposition pressure for Li-LiD.

Figure shows Li-LiD decomposition pressure between eutectic and monotectic points on the Li-LiD phase diagram.
Data are extrapolated down to 180 °C using results of: Veleckis E (1979) *J. Nucl. Mater.* 79 20-7.



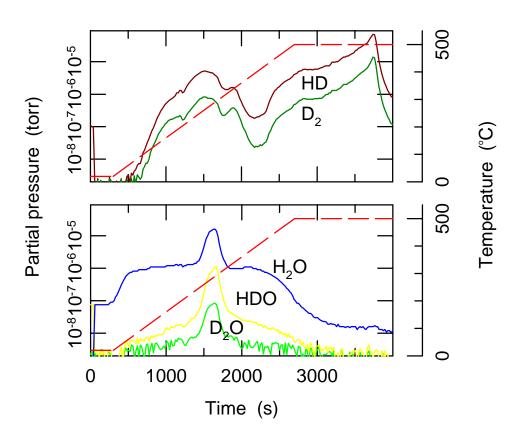
PISCES plasma exposure parameters.

• Samples of Li were exposed to deuterium plasma over a wide range of temperatures and ion fluence.

Parameter	
Ion flux (cm ⁻² s ⁻¹)	$10^{17} - 10^{18}$
Ion energy (bias) (eV)	50-100
Ion fluence (cm ⁻²)	$\sim 10^{20} - 10^{22}$
Sample temperature (°C)	40–400
Target materials	Solid and
	Liquid Li
Plasma species	D

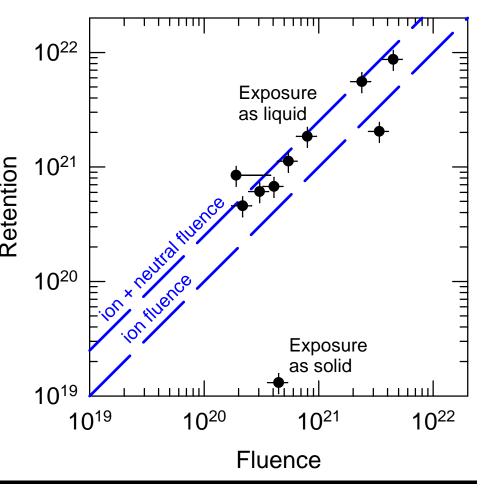
Retained D was measured using calibrated Thermal Desorption mass Spectrometry (TDS).

- Subsequent to exposure in PISCES each sample is out-gassed at temperatures up to 500 °C.
- This procedure involves fully evaporating all of the lithium from the sample holder.



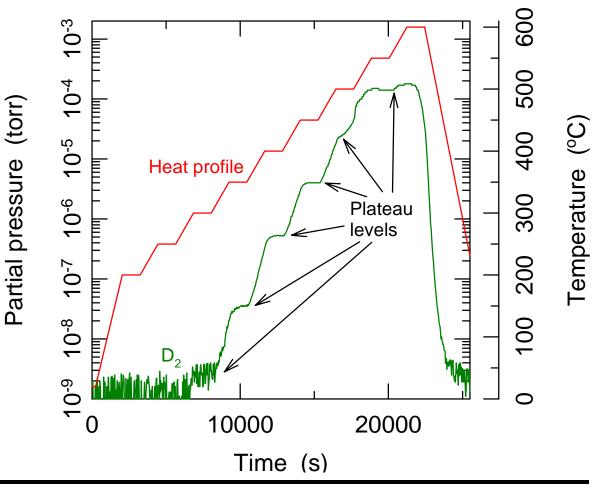
D Retention in liquid lithium exceeds 100 % of the incident ion fluence.

- Retained D at levels above 100% of the ion fluence indicate an additional source of species that the liquid Li will react with.
- Estimates of neutral atom flux due to charge exchange dissociation can account for the extra retained D.
- A liquid Li sample exposed to neutral D₂ molecules did not show any appreciable D uptake.



Controlled out-gassing may allow measurement of the deuterium recombination rate *K*.

• $J = Kc^2$ where J is the net flux of D atoms from the surface, and c is the concentration of D at the surface.



Concluding remarks

- We have experimentally observed large retention of hydrogen (>100 %) in liquid lithium by performing TDS on samples of Li exposed to a wide range of plasma ion fluences.
- Levels of retained D exceed the ion fluence. Initial estimates of neutral atom flux in PISCES due to charge exchange / dissociation seem to account for the extra retained D. A liquid Li sample exposed to neutral D₂ molecules did not show any appreciable D uptake.
- Similar measurements of He retention in liquid Li will soon commence.
- We are also exploring the possibility of using our TDS measurements to extract a measurement of the recombination rate for deuterium atoms at the sample surface.